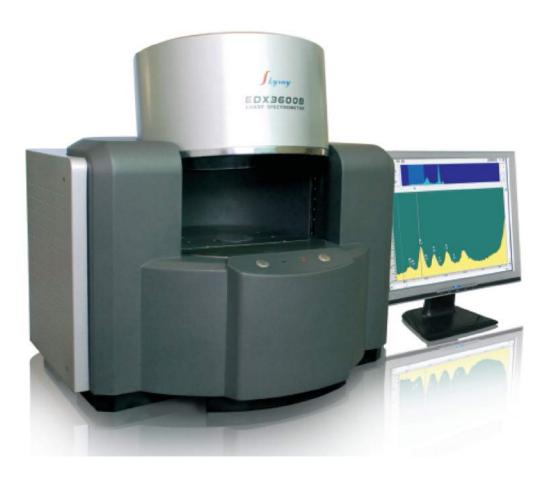


EDX 3600B

X-ray Fluorescence Spectrometer

Skyray Instruments USA Inc



EDX 3600B X-ray Fluorescence spectrometer uses XRF technology for rapid and accurate elemental analysis of cement and steel. The technology features low-energy X-rays specififcally for excitation of light elements such as Si, S, Na and Mg; and with automatic spectrum stabilizing EDX3600B delivers accurate results for light elements testing. UHRD detector provide excellent energy linearity, energy resolution and high peak-background ratio.

EDX3600B can be configured for many types of applications based on specific user analysis requirements.



EDX 3600B







Software Options

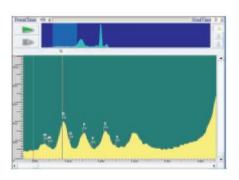
- Full-elemental analysis- Na-U
- RoHS/WEEE Analysis
- Mineral Analysis
- Alloy Analysis
- Custom calibrations for virtually any application

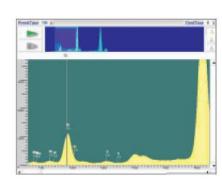
Technical Specifications

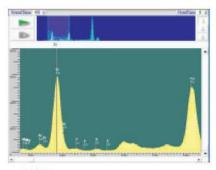
- Measurable elements: Na to U
- Range of element content: 1ppm-99.99%
- Ability of simultaneous analysis: 24 elements
- Plating thickness measurement: more than 11 layers, up to 0.005µm each layer
- Analysis accuracy: 0.05%
- Forms of samples: powder, solid and liquid
- Measurement time: 60s—200s
- Energy resolution: (150±5) eV
- Tube voltage: 5KV—50KV
- Tube current: 50uA—1000uA

Advantages

- Electric-cooling UHRD detector
- Signal-to-Noise Enhancer (SNE)
- Light path enhancement system
- High resolution CCD Camera
- Automatic collimator and filter switch
- Precise mobile platform
- Enhanced metal sensitivity

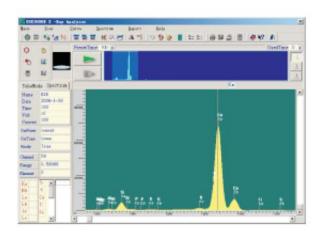








Analytical Software





Stability

Elements Times Results	Ca content	Na content	Mg content	Al content	Si content	K content	Ti content	Fe content	
Test1	44. 410	0. 458	3.563	4. 582	10.012	0.344	0.113	3. 388	200s
Test2	44.400	0.448	3.460	4.442	9. 801	0.352	0.113	3. 385	200s
Test3	44. 448	0.427	3.480	4. 493	9.954	0.347	0.112	3.368	200s
Test4	44.461	0.430	3.652	4.397	9.804	0.349	0.111	3.389	200s
Test5	44. 423	0.448	3.608	4.491	9.879	0.342	0.113	3.388	200s
Test6	44. 475	0.450	3.534	4.519	9.917	0.347	0.112	3.375	200s
Test7	44.446	0.444	3.782	4.663	9.934	0.351	0.111	3.389	200s
Test8	44.347	0.446	3.729	4.442	10.110	0.350	0.109	3.365	200s
Test9	44.355	0.450	3.560	4.450	10.090	0.352	0.111	3. 354	200s
Test10	44. 444	0.452	3. 581	4.359	10.076	0.350	0.113	3.374	200s
Test11	44. 444	0.464	3. 554	4.548	9.688	0.351	0.113	3. 372	200s
Test12	44. 429	0.448	3.655	4.499	9.789	0.352	0.113	3, 350	200s
Test13	44. 430	0.453	3.717	4. 521	10.093	0.350	0.113	3.359	200s
Test14	44. 490	0.451	3.779	4.466	10.206	0.348	0.111	3.362	200s
Test15	44. 462	0.446	3.679	4. 483	10.212	0.348	0.115	3.362	200s
Test16	44.494	0.445	3. 445	4. 426	10.044	0.355	0.109	3.350	200s
Test17	44. 440	0.435	3, 720	4.418	10.053	0.348	0.111	3.355	200s
Test18	44.418	0.438	3.640	4.543	10.067	0.354	0.108	3.369	200s
Test19	44. 428	0.427	3.705	4.359	10.310	0.350	0.112	3.371	200s
Test20	44. 551	0.466	3.646	4.659	10.391	0.350	0.110	3.368	200s
Average value of content	44.44	0.45	3.62	4.49	10.02	0.35	0.11	3.37	
Standard deviation of the measurement Sn	0.04	0.01	0.10	0.08	0.18	0.00	0.00	0.01	
3s value	0.13	0.03	0.29	0. 25	0.53	0.01	0.01	0.04	
Relative standard deviation RSD (%)	0.10%	2. 34%	2.71%	1.82%	1, 76%	0.86%	1.51%	0. 38%	

Skyray Instruments







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- Spectroscopy
- Chromatography Mass Spectrometry

Skyray Instruments specializes in the R&D, manufacturing and sales of analytical and measuring instruments in Spectroscopy, Chromatography and Mass Spectroscopy fields. Our Products include X-ray Fluorescence Spectrometry, Atomic Absorption Spectrometry, Gas Chromatography, Inductively Coupled Plasma Spectrometry, Mass Spectrometry and many others

Skyray has been providing customers around the world with reliable and affordable Scientific Instruments for more than 20 years

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